

Search for Vector-like Top Quarks in di-Leptons

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What is a vector-like quark

- They are not actually vector particles; they're spin 1/2 fermions.
- They're “vector-like” in that left and right helicity components have the same quantum numbers and transform identically under gauge transforms.

$$m\psi\bar{\psi}$$

- No Yukawa coupling (y)
They don't get their mass from the Higgs
- They are typically an expansion of the third generation rather than a 4th generation (T mixes with top), so they're not excluded by 4th gen searches.

$$\mathcal{L}_{\text{mass}} = - \begin{pmatrix} \bar{t}_L^0 & \bar{T}_L^0 \end{pmatrix} \begin{pmatrix} y_{33}^u \frac{v}{\sqrt{2}} & y_{34}^u \frac{v}{\sqrt{2}} \\ y_{43}^u \frac{v}{\sqrt{2}} & M^0 \end{pmatrix} \begin{pmatrix} t_R^0 \\ T_R^0 \end{pmatrix} \quad v \text{ is the Higgs VEV}$$



Motivation



THEORY

- VLQ's are **REQUIRED** if the Higgs is a pseudo-Goldstone boson, and in the partially-composite theories of flavor, including little Higgs and composite Higgs models.
- ➡ In both mechanisms, VLQ have sizable mixings with 3rd generation SM quarks, hence top and bottom partners.

OBSERVATION

- VLQs can improve the fit of electroweak observables to data:

$$\chi_{SM}^2 = 10.97, \chi_{VLQ}^2 = 1.61$$

ANALYSIS

- Largely model independent analysis
- Few free parameters.
- VLQ's are the simplest type of colored fermions still experimentally allowed.

Aguilar-Saavedra, Benbrikc, Heinemeyer, Pérez-Victoria



The cast of characters:

Particle ^{Elec. Charge}	Decays
$T^{2/3}$	bW^+, tH, tZ
$B^{-1/3}$	tW^-, bH, bZ
$X^{5/3}$	tW^+
$Y^{-4/3}$	bW^-

7 Allowed Combinations

Singlets	T B
Doublets	T, B T, X B, Y
Triplets	T, B, X T, B, Y

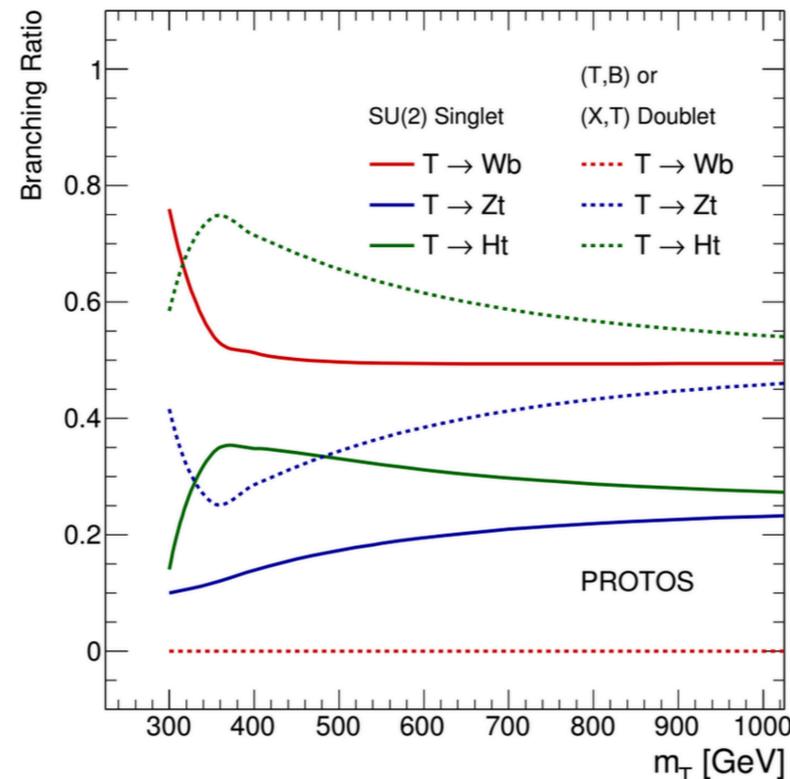
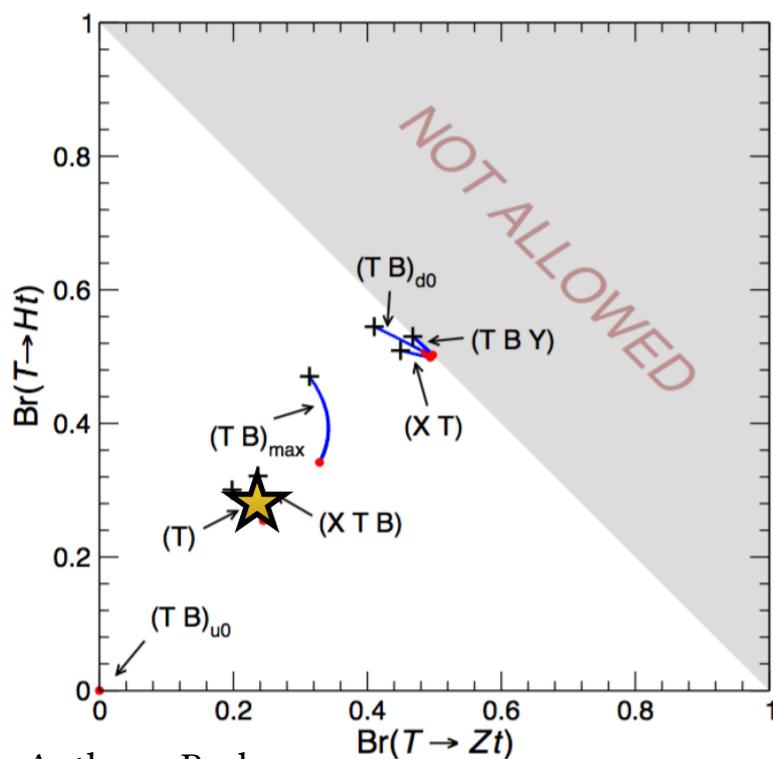
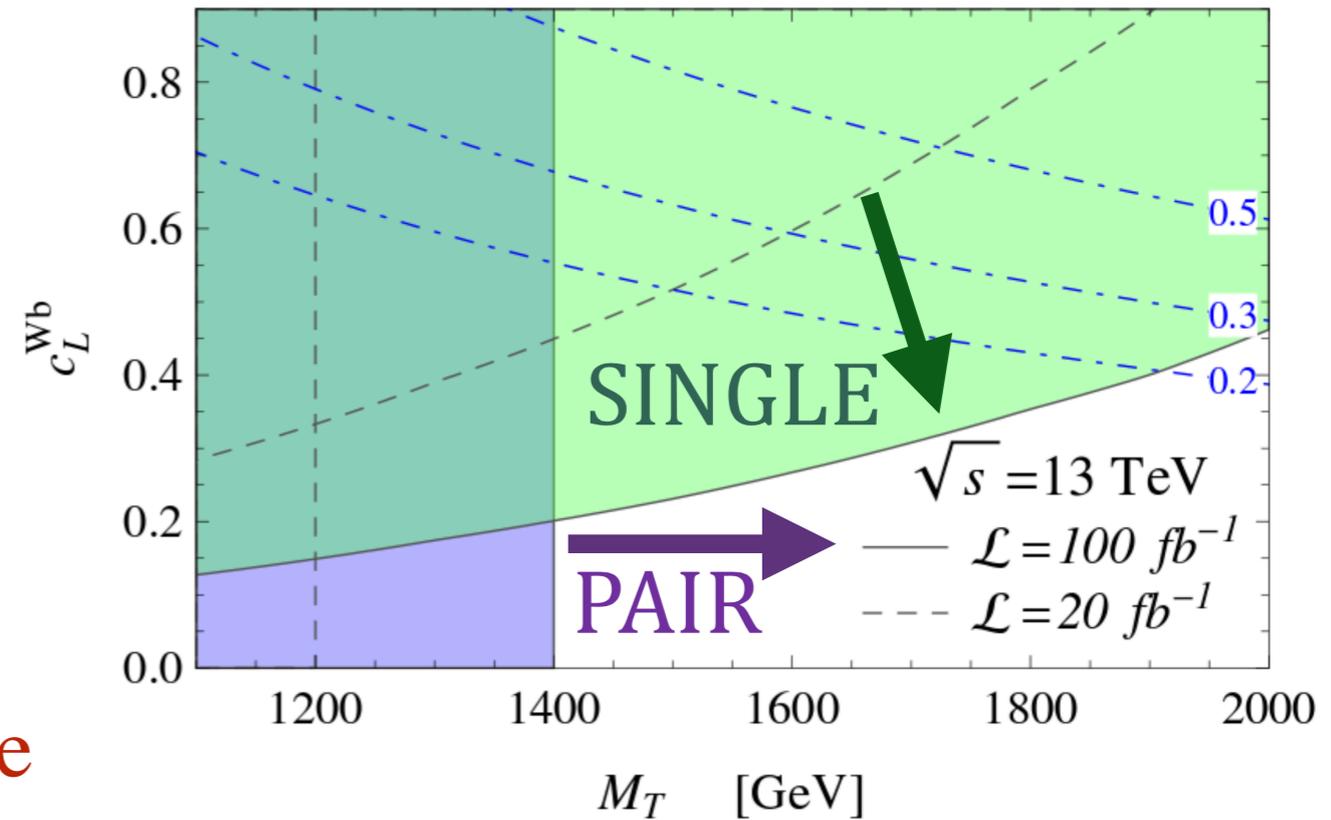


What they look like

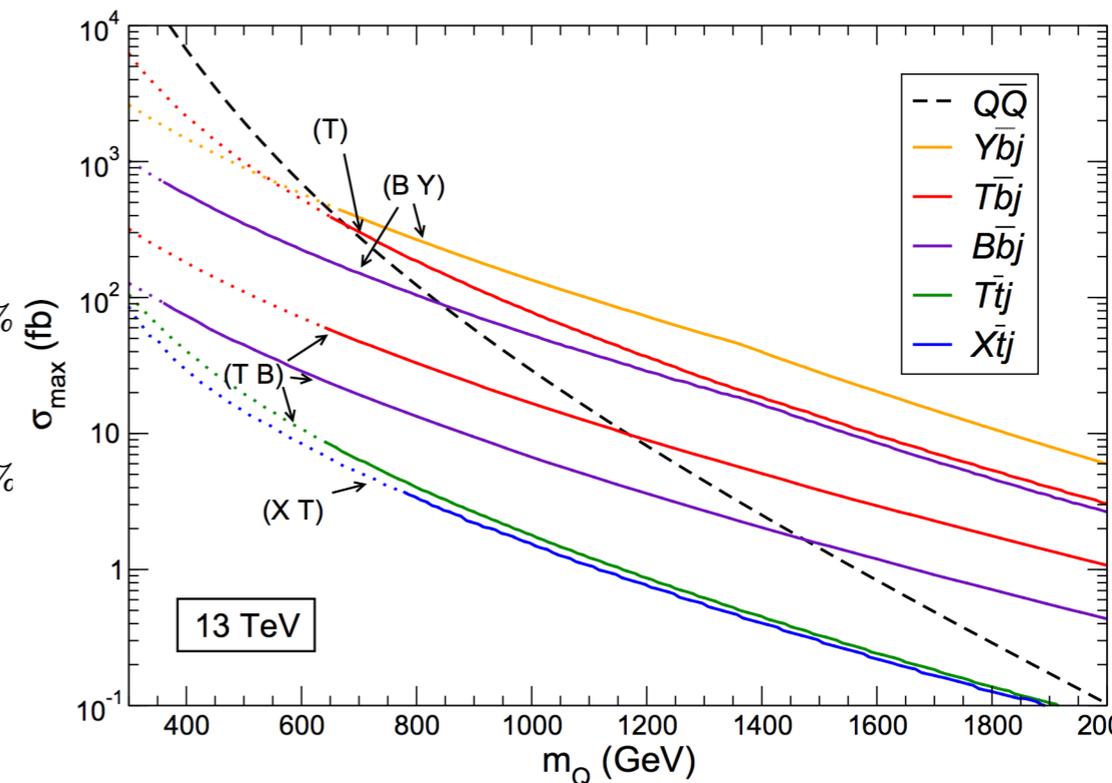


- VLQ can be produced singly or in pairs.
- Pair production is insensitive to couplings.
- Limits depend on the branching ratios—a function of multiplet and mass.
- **Complicated decays! Need multiple approaches and combined results.**

1311.7667 and 1311.7667



5





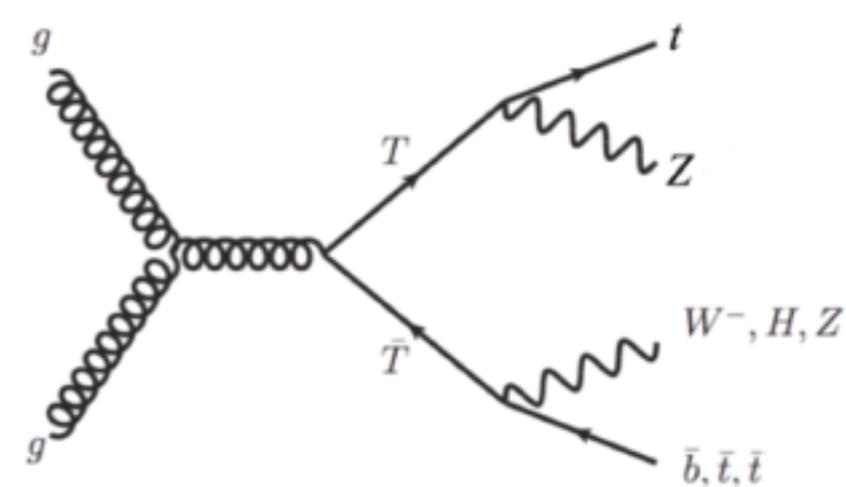
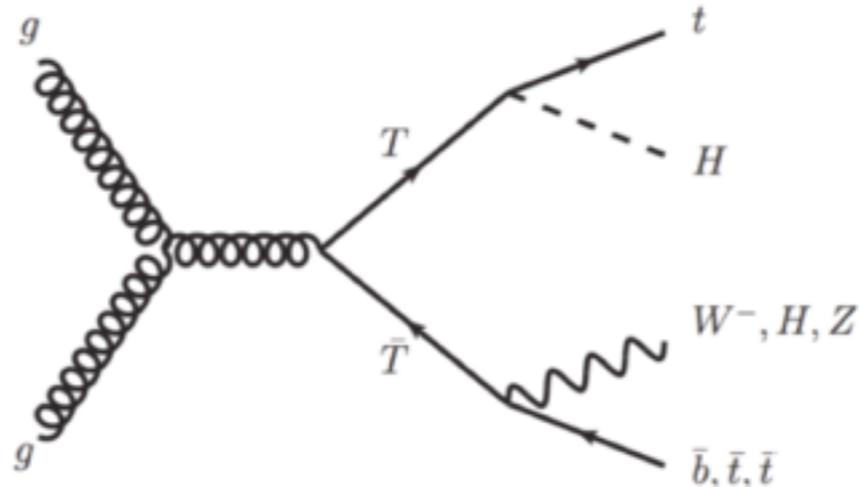
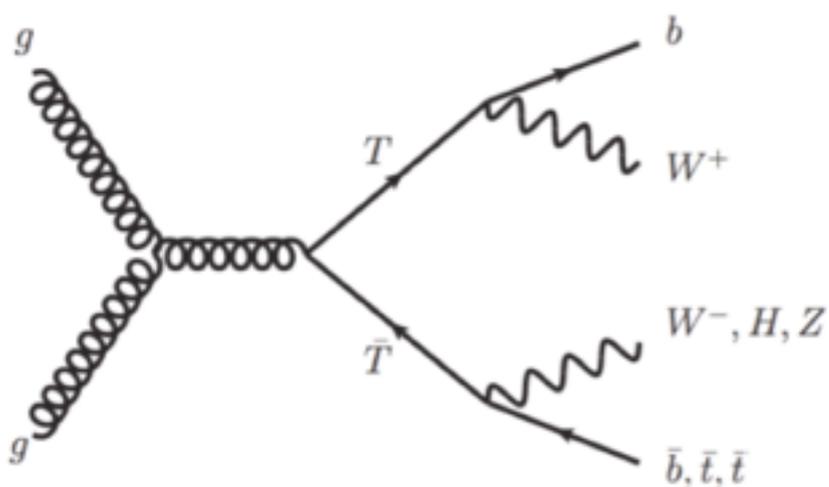
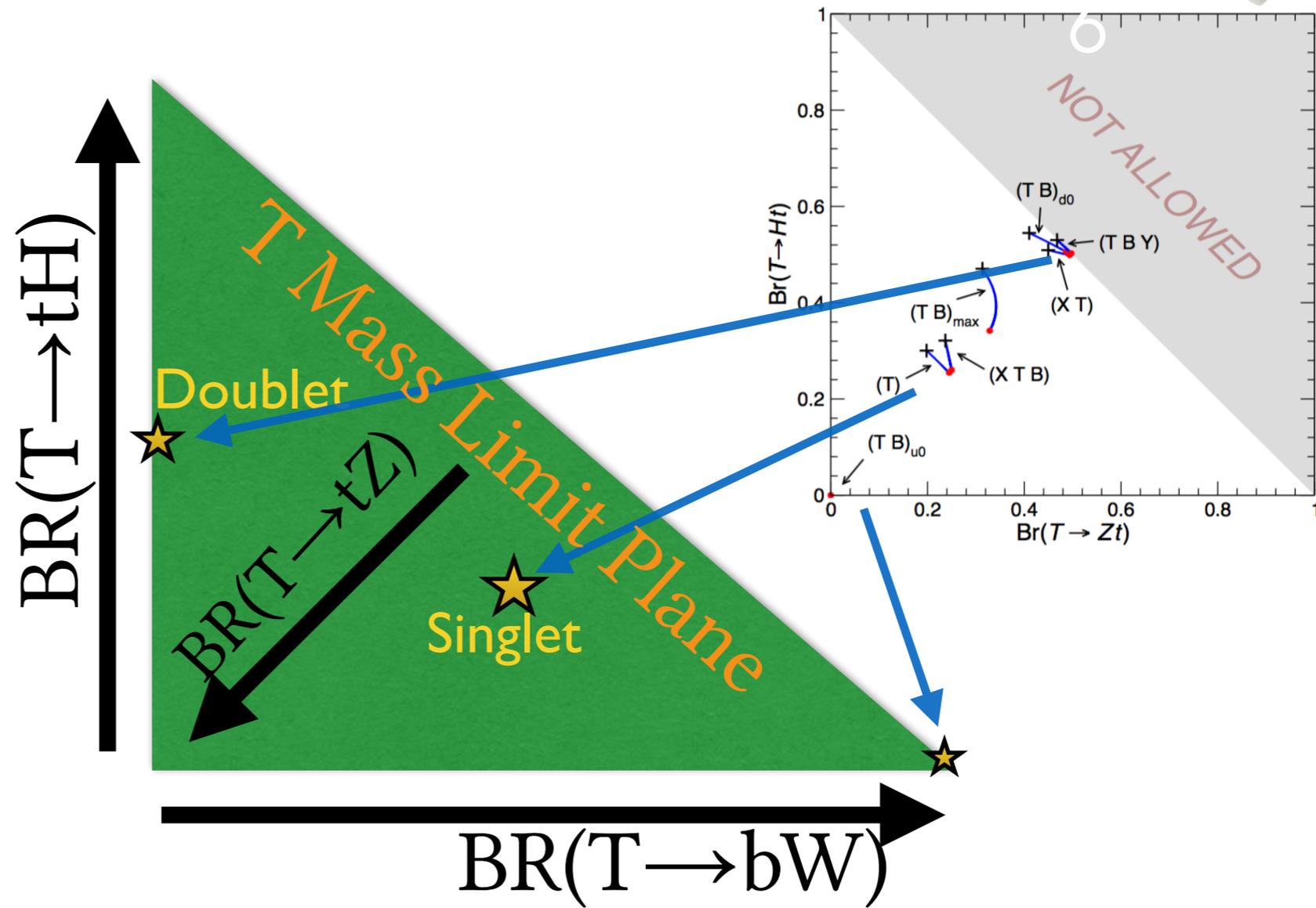
T' decay and Feynman diagrams



Complex decays,
thousands of final states

Need multiple analyses
combine

3 corners, many
possible approaches





Last Year's Limits



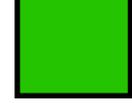
$M(T) \leq 850 \text{ GeV}$
Fully Excluded

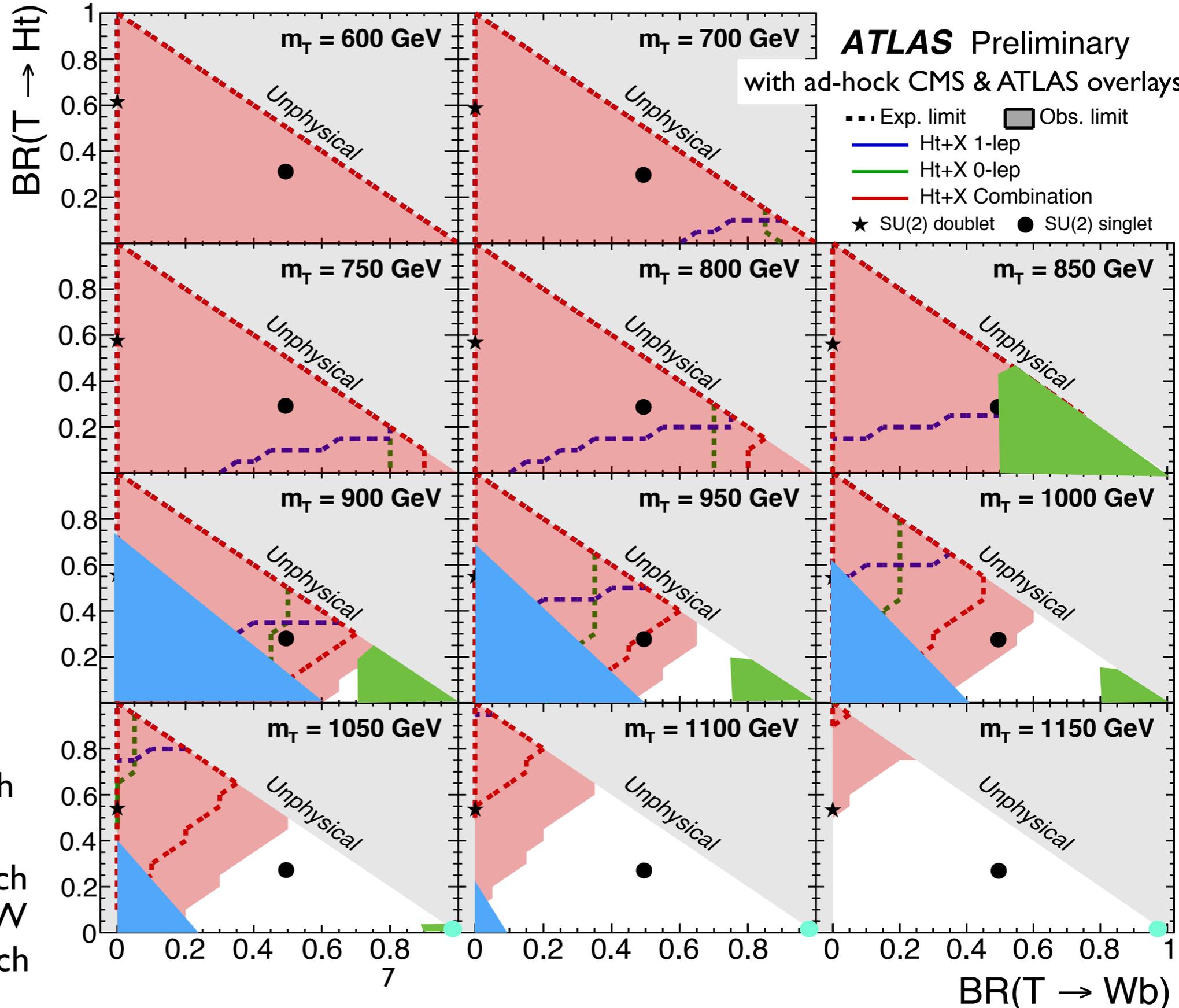
Singlet Excluded
below 1000 GeV

Doublet Excluded
below ~1150 GeV

Pure bW Excluded
below 1300 GeV

Incomplete list

-  Extant
-  Excluded by tH search
-  Excluded by l lep + MET search
-  Excluded by bW+hadrons search
-  Excluded by bWbW semi-leptonic search





Dilepton Channel

Part of a program of several lepton analyses

5% branching fraction of TT goes to dileptons



Di-Lepton Selection



▶ OSDL1 Channel

Targets $bWbW$

- ▶ 2 Tight OSDL
 - ▶ Z veto (76-106 GeV)
 - ▶ 2-3 Jets
 - ▶ ≥ 1 B-jet
 - ▶ $ST > 1000$ GeV
 - ▶ $\text{Min } M_{lb} > 170$ GeV
- Top Rejection

- ▶ $HT > 325$ GeV
- ▶ $MET > 30$ GeV,
- ▶ $M_{ll} > 20$ GeV

▶ SSDL Channel

Target $tH+X$

- ▶ 2 Tight SSDL
- ▶ ≥ 3 Jets
- ▶ ≥ 1 B-jet
- ▶ $ST > 1100$ GeV
- ▶ $HT > 500$ GeV
- ▶ $MET > 30$ GeV
- ▶ $M_{ll} > 20$ GeV

Ele Pt threshold: 30 GeV
Muon Pt threshold: 30 GeV

Data Driven Background Method for Dilepton

- Non-prompt and charge fake backgrounds are obtained using a matrix method that relates counts between selection regions using loose leptons, tight leptons, and charge match requirement inversion.
- Background is the expected number of events in tight-tight selection that do not originate from prompt leptons of the desired charge-match.
- The matrix method extends previous work by including charge-fake backgrounds in addition to the non-prompt background.
- Background contributions are handled event-by-event to account for the Pt and Eta dependence of the electron charge misID rate.

Observed counts

Counts of produced events destined to pass loose

Background contributions to tight-tight

$$\begin{pmatrix} n_{ttss} \\ n_{tlss} \\ n_{llss} \\ n_{ttos} \\ n_{tlos} \\ n_{llos} \end{pmatrix} = \begin{pmatrix} ap^2 & afp & af^2 & bp^2 & bfp & bf^2 \\ 2a(1-p)p & a(f(1-p) + (1-f)p) & 2a(1-f)f & 2b(1-p)p & b(f(1-p) + (1-f)p) & 2b(1-f)f \\ a(1-p)^2 & a(1-f)(1-p) & a(1-f)^2 & b(1-p)^2 & b(1-f)(1-p) & b(1-f)^2 \\ bp^2 & bfp & bf^2 & ap^2 & afp & af^2 \\ 2b(1-p)p & b(f(1-p) + (1-f)p) & 2b(1-f)f & 2a(1-p)p & a(f(1-p) + (1-f)p) & 2a(1-f)f \\ b(1-p)^2 & b(1-f)(1-p) & b(1-f)^2 & a(1-p)^2 & a(1-f)(1-p) & a(1-f)^2 \end{pmatrix} \begin{pmatrix} N_{ppss} \\ N_{pfss} \\ N_{ffss} \\ N_{ppos} \\ N_{pfos} \\ N_{ffos} \end{pmatrix}$$

$a = (1 - q_1)(1 - q_2) + q_1q_2$
 $b = q_1(1 - q_2) + q_2(1 - q_1)$
 q_1 is the charge mistag probability for electron 1; q_2 is the charge mistag probability for electron 2

Probability matrix to be inverted



Fake Rate

Prompt Rate

Charge-flip Rate

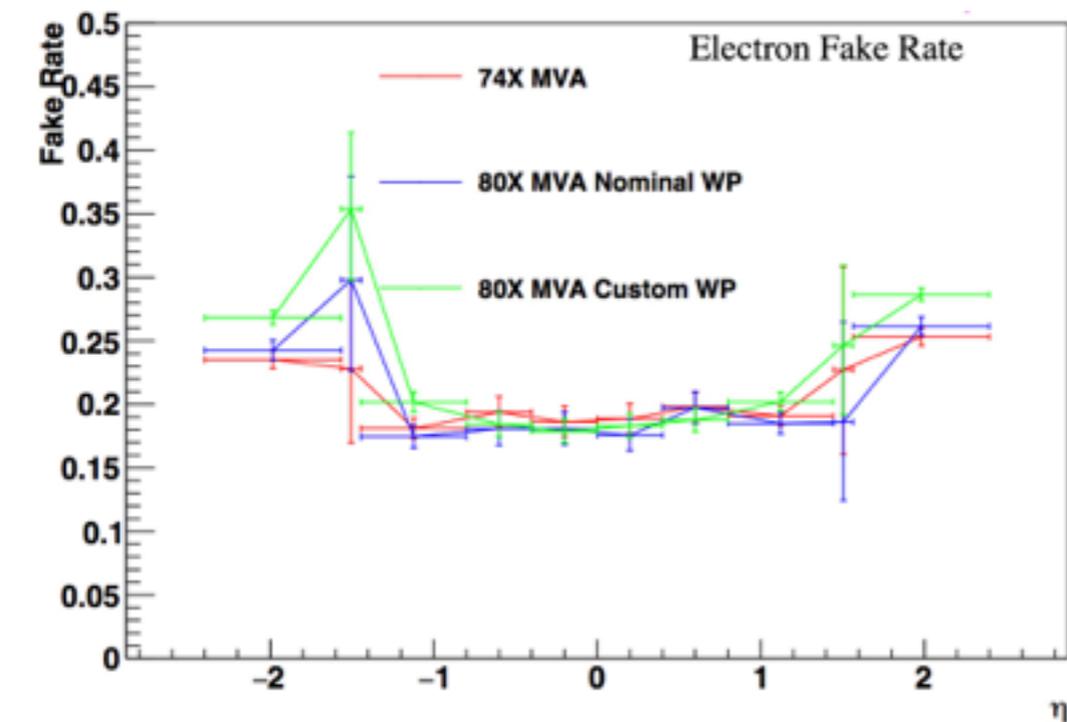
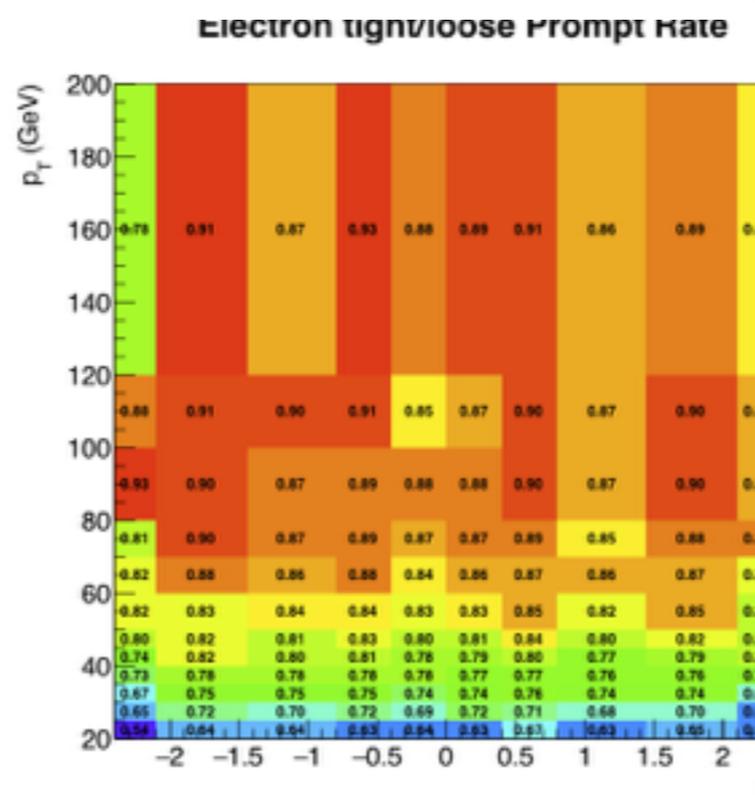
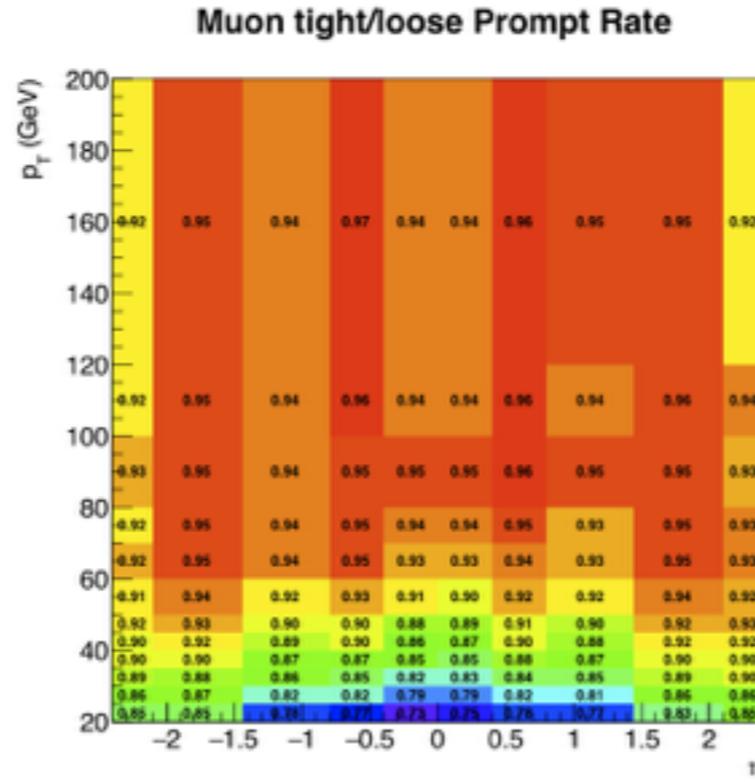
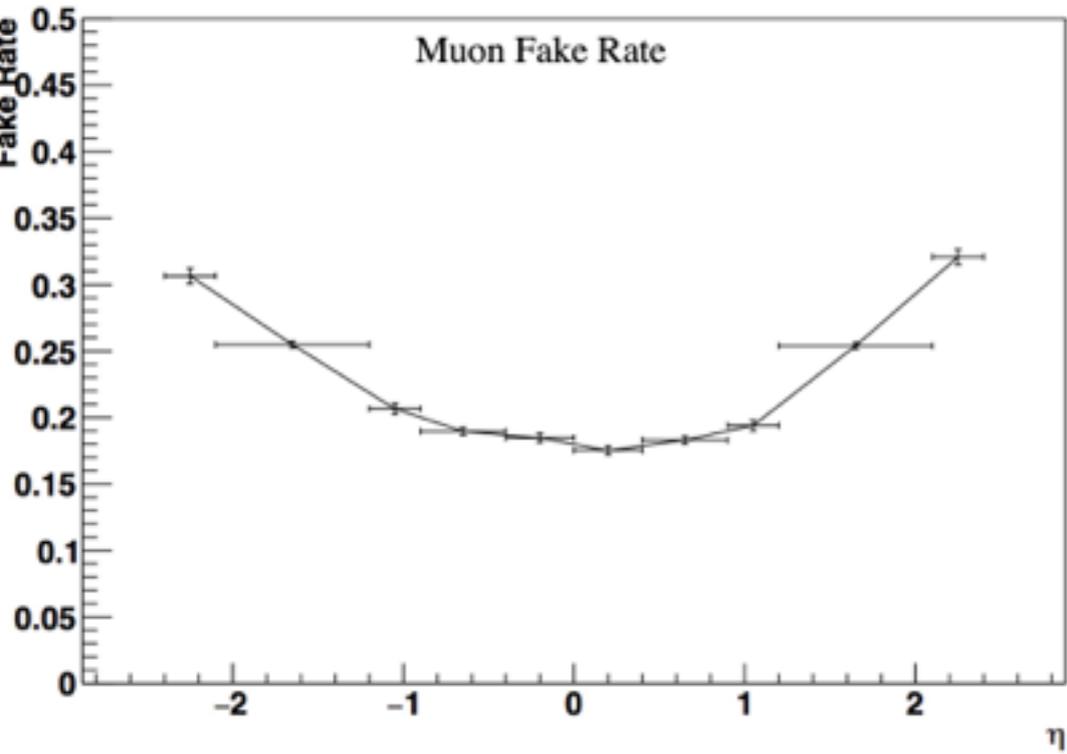


Measured inputs to data driven background method

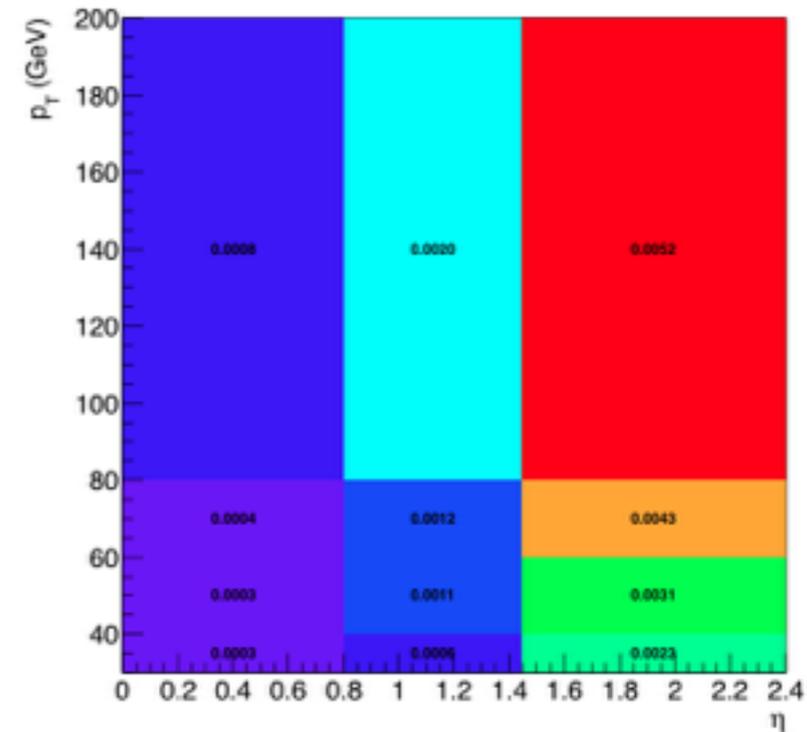
Work in Progress

Fake rate measured in Lep+Jet data

Prompt and charge flip measured in DY data



Electron Charge mis-ID Rate

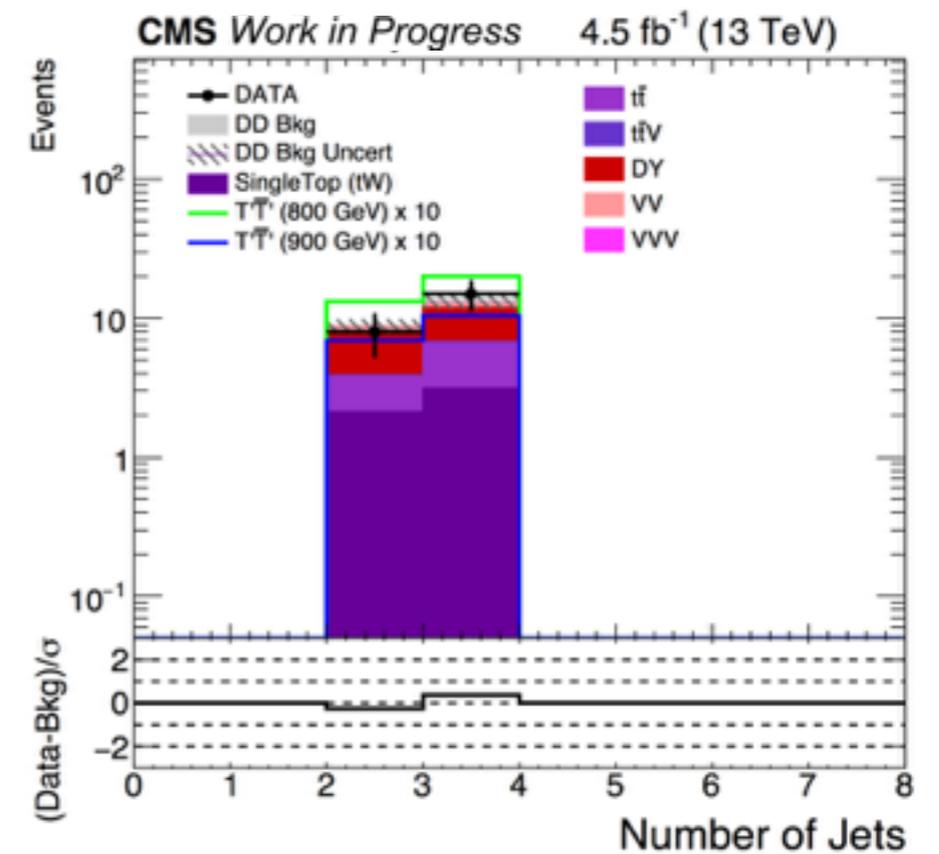
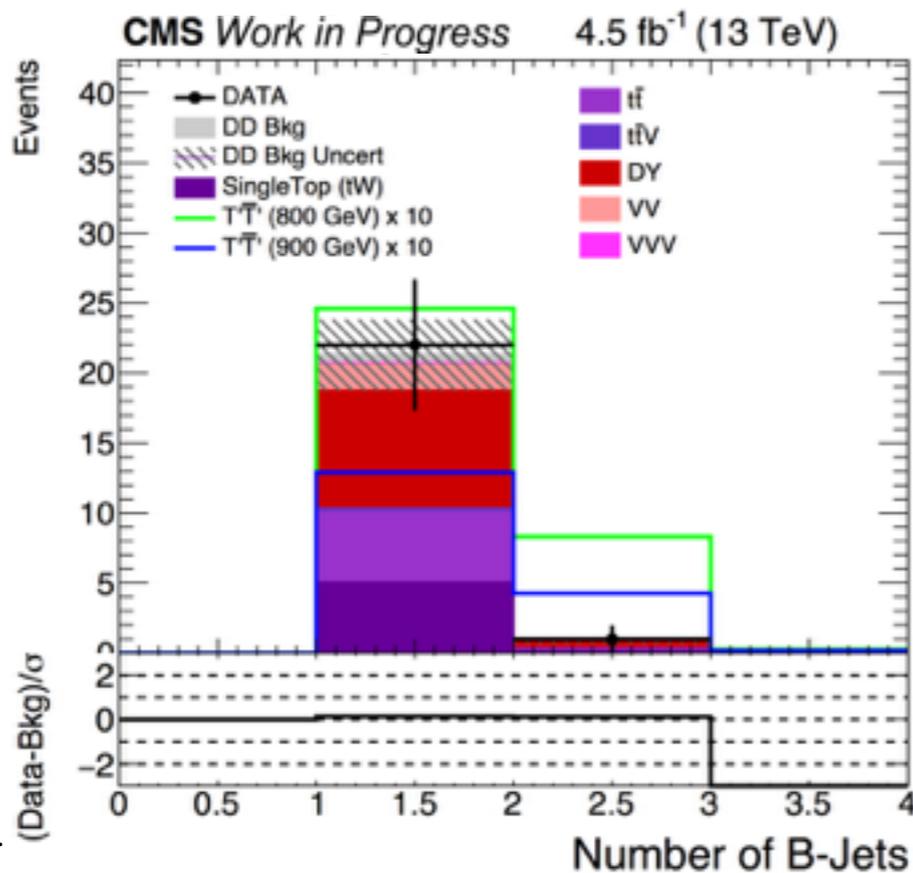
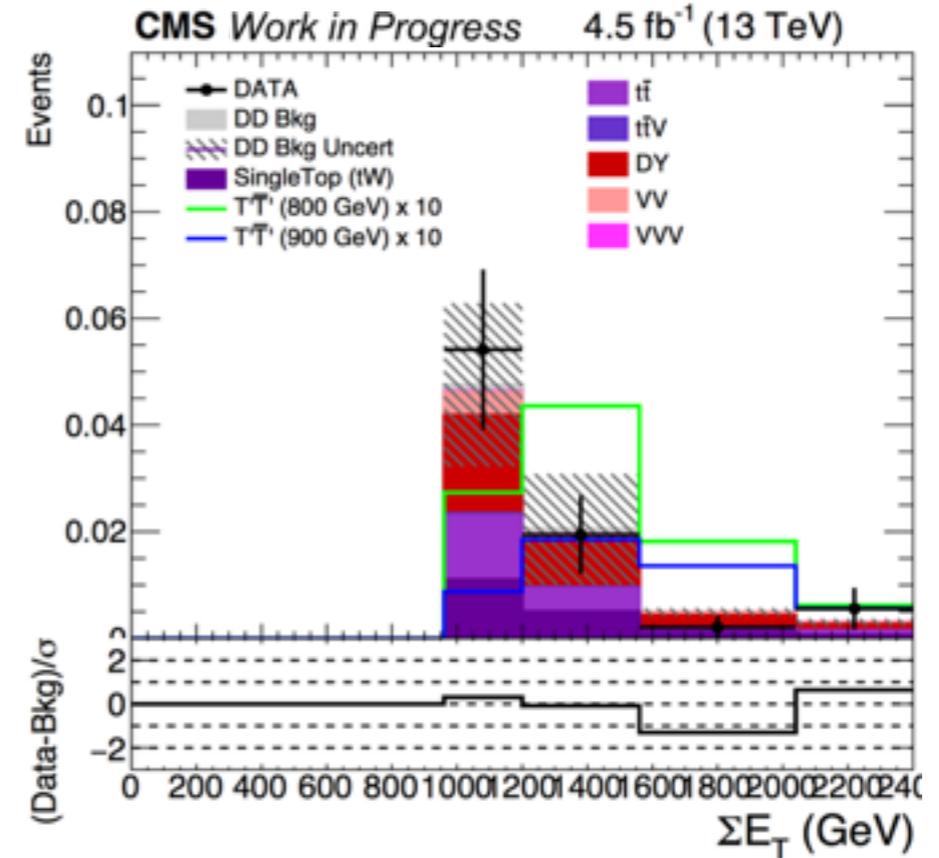




Result Plots



- Significant reliance on MC
- 12 systematic uncertainties just from MC
- 17 systematic uncertainties total
- Prescaled 8x for partial blinding



Back-up

CMS & ATLAS 8 TeV Limits

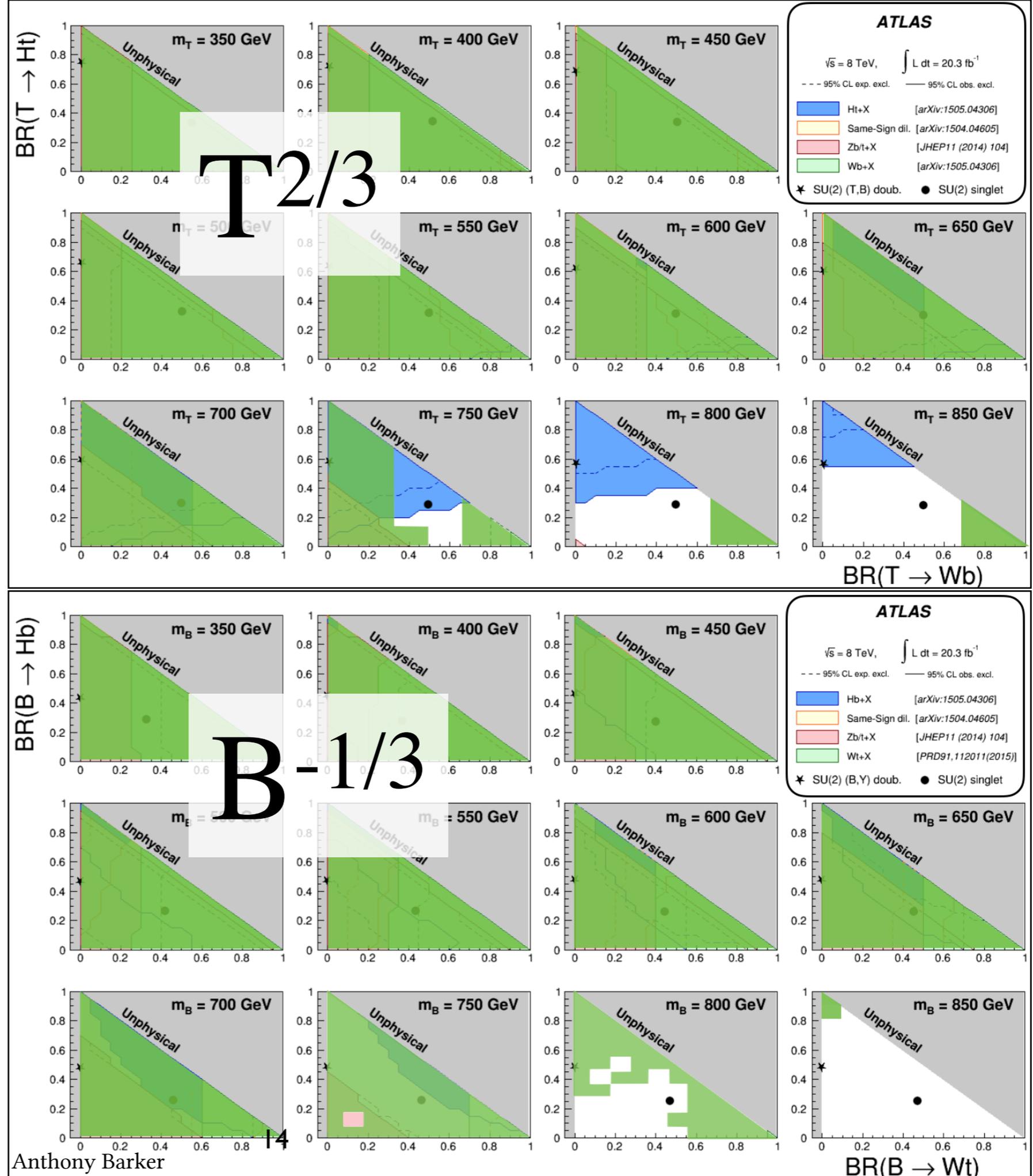
CMS Exclusion
Overlay

White = Extant

[ATLAS Results page](#)

CMS $T^{2/3}$: [B2G-13-005](#)

CMS $B^{1/3}$: [B2G-13-006](#)



Branching fractions of TT

Branching fractions in TT

Process	DL	OSDL	OSSF	OSOF	SSDL	SSSF	SSOF
TT	0.076	0.070	0.046	0.025	0.006	0.003	0.003
bWbW	0.011	0.011	0.006	0.006	0	0	0
bWtZ	0.021	0.021	0.016	0.005	0	0	0
bWtH	0.018	0.015	0.008	0.007	0.003	0.002	0.002
tHtH	0.006	0.005	0.003	0.002	0.002	0.001	0.001
tHtZ	0.013	0.012	0.008	0.003	0.001	0.001	0.001
tZtZ	0.007	0.007	0.006	0.001	0	0	0
bW+X	0.050	0.047	0.029	0.018	0.003	0.002	0.002
bW+tV	0.039	0.036	0.023	0.012	0.003	0.002	0.002
tH+X	0.038	0.032	0.019	0.013	0.006	0.003	0.003
tH+not tH	0.031	0.027	0.016	0.011	0.004	0.002	0.002
tZ+X	0.041	0.039	0.030	0.010	0.001	0.001	0.001
tZ+not tZ	0.034	0.032	0.024	0.008	0.001	0.001	0.001
All not bWbW	0.065	0.059	0.040	0.019	0.006	0.003	0.003

- Analyzed with Particle Branch Ratio Counter
- Full decay tree explored, including all permutations of final states.

Proportion of each column by source

Process	DL	OSDL	OSSF	OSOF	SSDL	SSSF	SSOF
TT	1	1	1	1	1	1	1
bWbW	0.144	0.156	0.120	0.224	0	0	0
bWtZ	0.269	0.292	0.339	0.205	0	0	0
bWtH	0.24	0.22	0.17	0.30	0.51	0.51	0.51
tHtH	0.08	0.07	0.05	0.09	0.25	0.25	0.25
tHtZ	0.17	0.17	0.18	0.14	0.23	0.23	0.23
tZtZ	0.093	0.101	0.130	0.047	0	0	0
bW+X	0.65	0.66	0.63	0.73	0.51	0.51	0.51
bW+tV	0.51	0.51	0.51	0.50	0.51	0.51	0.51
tH+X	0.494	0.451	0.411	0.525	1	1	1
tH+not tH	0.41	0.38	0.36	0.43	0.75	0.75	0.75
tZ+X	0.53	0.56	0.65	0.39	0.23	0.23	0.23
tZ+not tZ	0.44	0.46	0.52	0.34	0.23	0.23	0.23
All not bWbW	0.856	0.844	0.880	0.776	1	1	1

- tH(WW) is necessary on at least one branch for SSDL
- second lepton usually from a top, or W on the other branch.



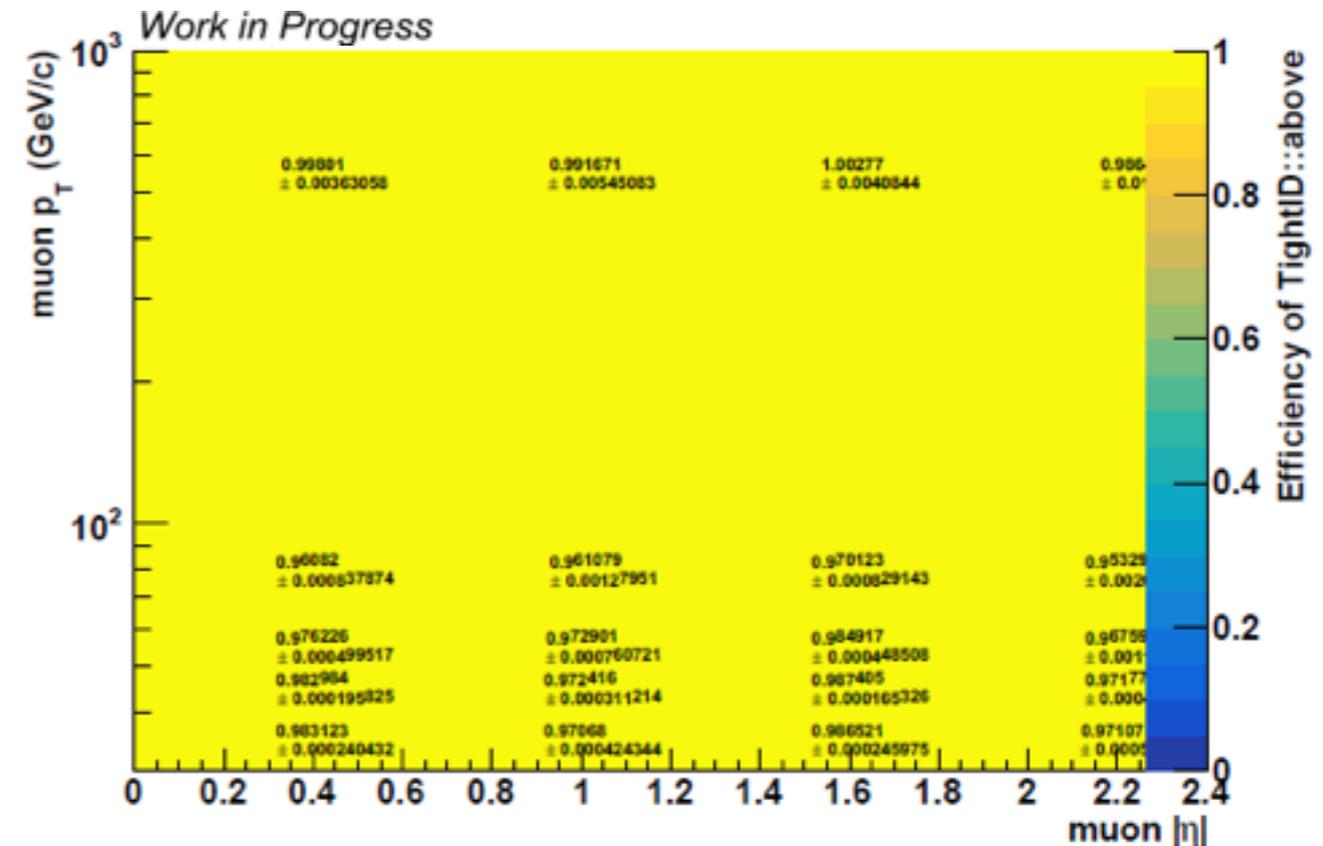
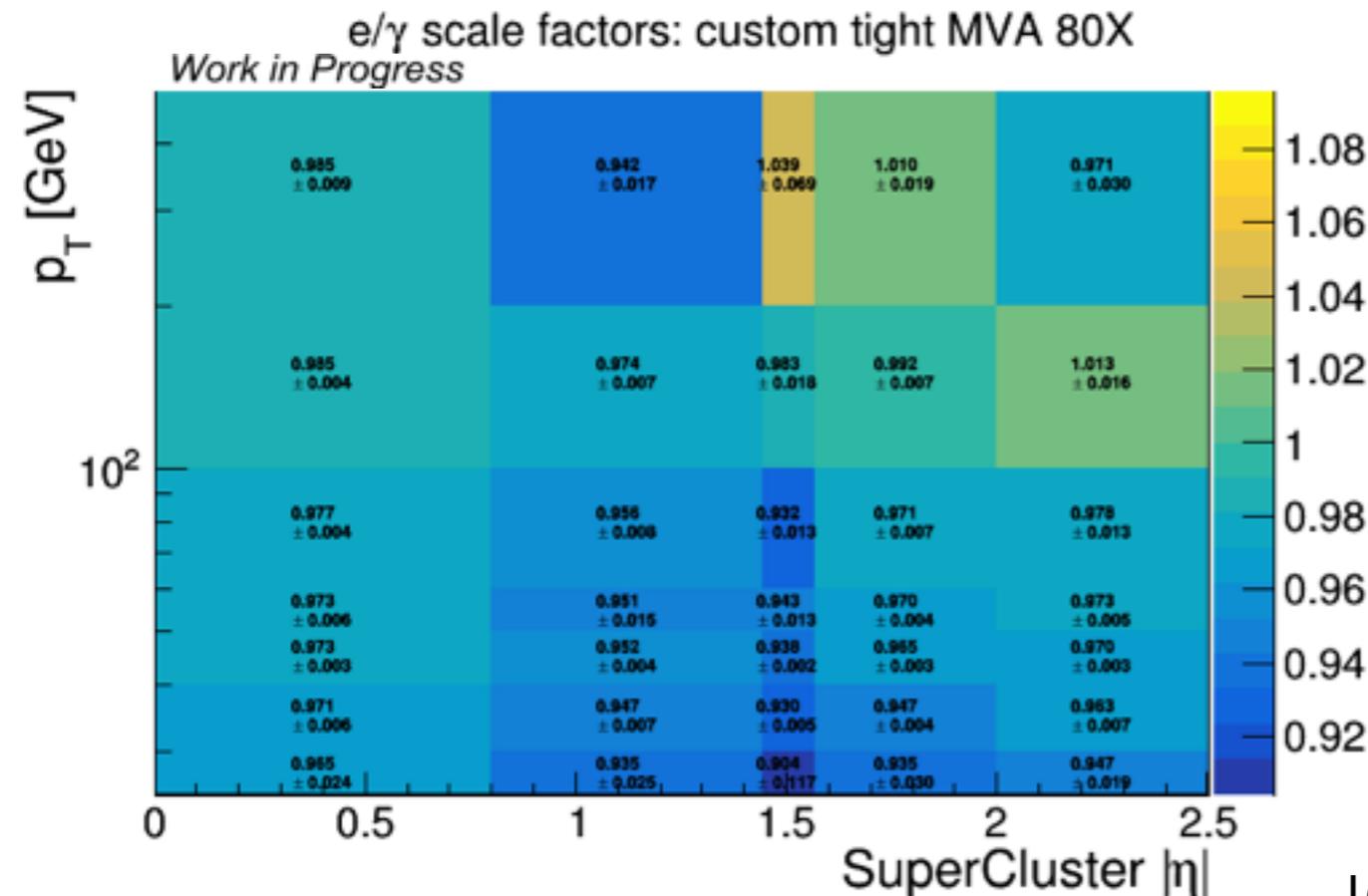
Electrons

- $P_t > 30$, $|E_{\text{tal}}| < 2.4$
- mini-iso < 0.1 for tight
- mini-iso < 0.4 , used for background studies
- Custom MVA working point
- Electron scale factors



Muons

- $P_t > 30$, $|E_{\text{tal}}| < 2.4$
- mini-iso < 0.1 for Tight
- mini-iso < 0.4 for background studies
- Muon scale factors





Systematic Uncertainties

- All of the following systematic uncertainties are included and fully implemented as shape uncertainties:
 - Renormalization scale uncertainty
 - Parton Shower E Scale uncertainty
 - PDF uncertainty
 - Jet scale factor uncertainty
 - Jet Energy Scale uncertainty
 - Jet energy resolution uncertainty
 - B-tagging scale factor uncertainty
 - light-jet ID scale factor uncertainty
 - HLT
 - Lepton ID SF uncertainty
 - Lepton Iso SF uncertainty
 - Top Pt reweighting
- Simple constant uncertainties:
 - Lumi uncertainty
- Bin-by-bin
 - Statistical (on plots)
 - Prompt rate uncertainty
 - Fake rate uncertainty
 - Charge flip uncertainty